


<b>Search Notes</b>  	<b>Application/Control No.</b>  10662407	<b>Applicant(s)/Patent Under Reexamination</b>  EKBERG ET AL.
	<b>Examiner</b>  Ho, Huy C	<b>Art Unit</b>  2617

### SEARCHED

Class	Subclass	Date	Examiner
709	228	5/25/07	HH
370	338	5/25/07	HH

### SEARCH NOTES

Search Notes	Date	Examiner
EAST image and keyword search in USPATConclusion, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM, TDB (See attached search strat	1/18/07	HH
Search updated	5/25/07	HH
Search updated	11/9/2007	HH
Search updated	5/16/2008	HH

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner